FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets If necessary) (37 CFR 1.98(b)

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ATTY. DOCKET NO.

Magnus HELLSTRAND

FILING DATE
May 24, 2000

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EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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## FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

		DOCUMENT NO.	PUBL. DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANSLATION YES NO
M	AL	0 197 598	10/86	EUROPE			NO
ay	AM	0 425 882	5/91	EUROPE			YES
ay	AN	WO 98/50196	11/98	INTERNATIONAL			YES
	АО						
	AP						

## OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)

ay		F.R. BODDEKE et al., "Autofocusing in Microscopy Based On The OTF And Sampling", November 22, 1994, <u>IOP PUBLISHING</u> LTD., Bioimaging 2, 193-203.
	AS	

**EXAMINER** 

DATE CONSIDERED

1/23/04

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.